

#### 1200V 75A Trench and Field Stop IGBT

#### JJT75N120HA

### Key performance:

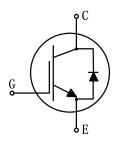
- $V_{\rm CE} = 1200 {\rm V}$
- $I_{\rm C}=75{\rm A}@T_{\rm C}=100^{\circ}{\rm C}$
- $V_{CE(sat)}=2.0V$

#### **Features:**

- Trench and field-stop technology
- Easy parallel switching capability
- Low V<sub>CEsat</sub>
- High ruggedness performance
- RoHS compliant

### TO-247PLUS





### **Applications:**

- Solar converters
- On-Board Charger

#### **Package parameters**

Туре	Marking	Package	Packaging Method
JJT75N120HA	T75120HA	TO-247PLUS	Tube

# Maximum ratings

Symbol	Parameter	Values	Unit
V <sub>CES</sub>	Collector-emitter voltage	1200	V
V <sub>GES</sub>	Gate-emitter voltage	±20	V
I	Continuous collector current ( $T_{\rm C}=25^{\circ}{\rm C}$ )	150	А
Ic	Continuous collector current ( $T_{\rm C}$ =100°C)	75	А
Ісм	Pulsed collector current, $t_p$ limited by $T_{vjmax}$	300	А
IF	Diode continuous forward current ( $T_{\rm C}$ =100°C)	75	А
I <sub>FM</sub>	Diode maximum current, $t_p$ limited by $T_{vjmax}$	150	А
D	Power dissipation ( $T_{\rm C}$ =25°C)	1456	W
P <sub>tot</sub>	Power dissipation ( $T_{\rm C}$ =100°C)	728	W
T <sub>vj</sub>	Operating junction temperature range	-40 to +175	°C
$T_{\rm stg}$	Storage temperature range	-55 to +150	°C

### **Thermal characteristics**

6 h - l	D	Val	Unit	
Symbol	Parameter			Max.
$R_{ m th(j-c)}$	Thermal resistance, junction to case for IGBT	-	0.10	K/ W
$R_{ m th(j-c)}$	Thermal resistance, junction to case for Diode	-	0.44	K/ W
R <sub>th(j-a)</sub>	Thermal resistance, junction to ambient	-	40	K/ W

### **Electrical characteristics of IGBT** $(T_{vj}=25^{\circ}C \text{ unless otherwise specified})$

### Static characteristics

Shl	Demorrador	T	Values			TI
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
BV <sub>CES</sub>	Collector-emitter breakdown voltage	$V_{\rm GE}$ =0V, I <sub>C</sub> =250 $\mu$ A	1200	-	-	V
I <sub>CES</sub>	Collector-emitter leakage current	$V_{\rm CE}$ =1200V, $V_{\rm GE}$ =0V	-	-	100	μΑ
IGES       Gate leakage current, forward         Gate leakage current, reverse	Gate leakage current, forward	$V_{\rm GE}$ =20V, $V_{\rm CE}$ =0V	-	-	100	nA
	Gate leakage current, reverse	$V_{\rm GE}$ =-20V, $V_{\rm CE}$ =0V	-	-	-100	nA
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	$V_{\rm GE} = V_{\rm CE}, I_{\rm C} = 1  {\rm mA}$	5.2	5.6	6.0	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	$V_{\rm GE}$ =15 V, $I_{\rm C}$ =75A	-	2.0	-	V
		$V_{\rm GE}$ =15V, $I_{\rm C}$ =75A, $T_{\rm vj}$ =175°C	-	2.6	-	V

### Dynamic characteristics

Symbol	Parameter	Test condition	Values			<b>T</b> I
Symbol			Min.	Тур.	Max.	Unit
C <sub>ies</sub>	Input capacitance	- <i>V</i> <sub>CE</sub> =30V	-	18650	-	pF
C <sub>oes</sub>	Output capacitance	$V_{\text{GE}}=0$ V	-	340	-	pF
C <sub>res</sub>	Reverse transfer capacitance	f=1MHz		80	-	pF
Qg	Total gate charge	$V_{CC}=960V$ $V_{GE}=15V$ $I_{C}=75A$	-	560	-	nC

# Switching characteristics

	Parameter			Values		
Symbol		Test condition	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	138	-	ns
t <sub>r</sub>	Rise time	<i>V</i> <sub>CC</sub> =600V	-	120	-	ns
$t_{\rm d(off)}$	Turn-off delay time	$V_{\rm GE} = 0/15V$ $I_{\rm C} = 75A$	-	676	-	ns
$t_{ m f}$	Fall time	$R_{\rm G}=10\Omega$	-	71	-	ns
$E_{\rm on}$	Turn-on energy	Inductive load	-	7.7	-	mJ
$E_{\rm off}$	Turn-off energy		-	3.7	-	mJ
$E_{ m ts}$	Total switching energy		-	11.4	-	mJ
t <sub>d(on)</sub>	Turn-on delay time		-	124	-	ns
t <sub>r</sub>	Rise time		-	121	-	ns
t <sub>d(off)</sub>	Turn-off delay time	$V_{CC}=600V$ $V_{GE}=0/15V$	-	691	-	ns
t <sub>f</sub>	Fall time	$I_{C}=75A$ $R_{G}=10\Omega$	-	82	-	ns
$E_{ m on}$	Turn-on energy	Inductive load $T_{vj}=175^{\circ}C$	-	8.4	-	mJ
$E_{\rm off}$	Turn-off energy		-	4.1	-	mJ
$E_{\rm ts}$	Total switching energy		-	12.5	-	mJ

	Symbol Parameter	T 4 l'd'	Values			TL.º4
Symbol		Test condition	Min.	Тур.	Max.	Unit
IZ.		<i>I</i> <sub>F</sub> =75A	-	2.1	-	V
$V_{\rm F}$	Diode forward voltage	<i>I</i> <sub>F</sub> =75A, <i>T</i> <sub>vj</sub> =175℃	-	1.8	-	V
t <sub>rr</sub>	Diode reverse recovery time	$V_{\rm R}$ =600V	-	163	-	ns
I <sub>rrm</sub>	Diode peak reverse recovery current	$I_{\rm F}=75{\rm A}$	-	20	-	А
$Q_{ m rr}$	Diode reverse recovery charge	$d_{\rm F}/dt$ =-600A/µs	-	2046	-	nC
t <sub>rr</sub>	Diode reverse recovery time	$V_{\rm R}$ =600V	-	278	-	ns
I <sub>rrm</sub>	Diode peak reverse recovery current	$I_{\rm F}=75{\rm A}$ $di_{\rm F}/dt=-600{\rm A}/\mu{\rm s}$	-	39	-	А
$Q_{ m rr}$	Diode reverse recovery charge	<i>T</i> <sub>vj</sub> =175 ℃	-	6679	-	nC

### **Electrical characteristics of Diode** $(T_{vj}=25^{\circ}C \text{ unless otherwise specified})$

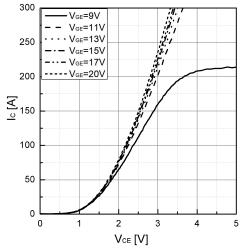


Fig 1. Typical output characteristic ( $T_{vj}=25^{\circ}C$ )

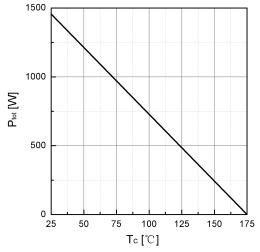
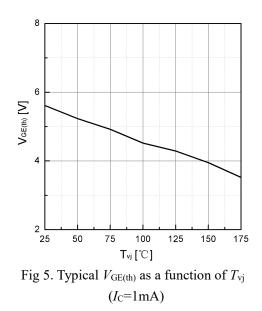


Fig 3. Power dissipation as a function of  $T_C$ 



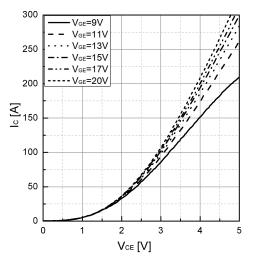
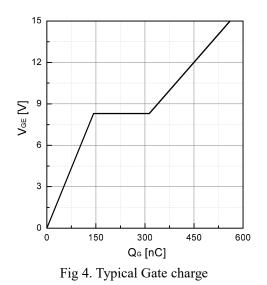


Fig 2. Typical output characteristic( $T_{vj}=175^{\circ}C$ )



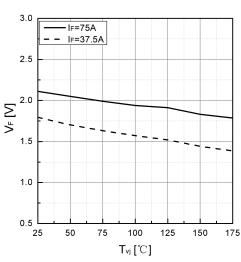


Fig 6. Typical  $V_{\rm F}$  as a function of  $T_{\rm vj}$ 

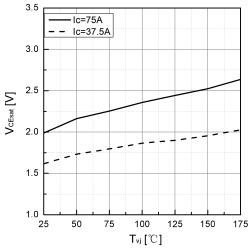


Fig 7. Typical  $V_{\text{CEsat}}$  as a function of  $T_{\text{vj}}$ 

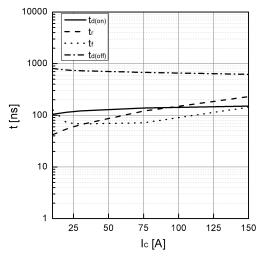


Fig 9. Typical switching time as a function of  $I_{\rm C}$ 

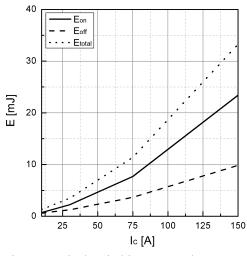


Fig 11. Typical switching energy losses as a function of  $I_{\rm C}$ 

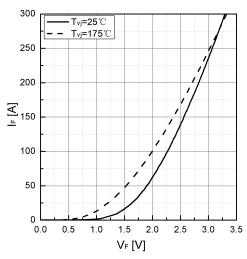


Fig 8. Typical  $I_{\rm F}$  as a function of  $V_{\rm F}$ 

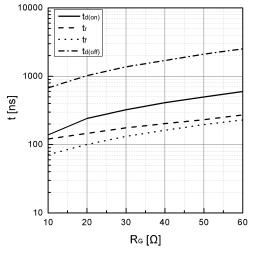


Fig 10. Typical switching times as a function of  $R_{\rm G}$ 

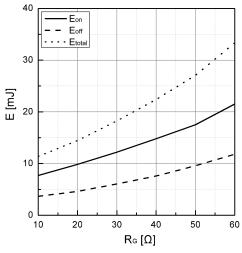


Fig 12. Typical switching energy losses as a function of  $R_{\rm G}$ 

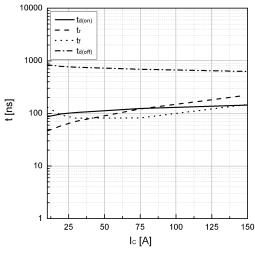


Fig 13. Typical switching time as a function of  $I_{\rm C}$ 

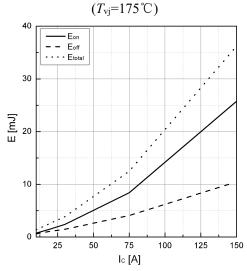
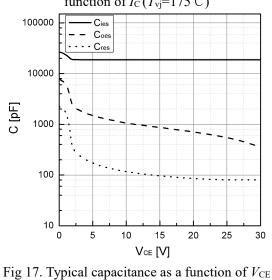


Fig 15. Typical switching energy losses as a function of  $I_{\rm C}(T_{\rm vj}=175^{\circ}{\rm C})$ 



 $(f=1Mhz, V_{GE}=0V)$ 

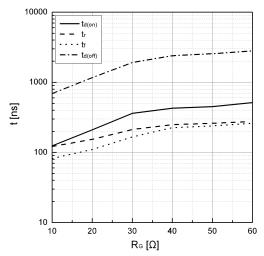


Fig 14. Typical switching times as a function of  $R_{\rm G}$  $(T_{\rm vi}=175^{\circ}{\rm C})$ 

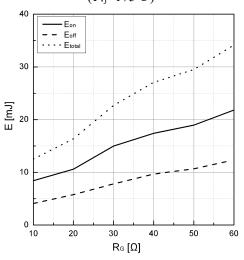
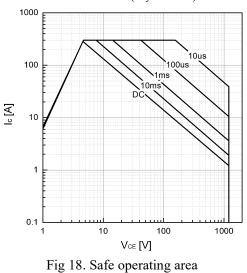


Fig 16. Typical switching energy losses as a function of  $R_G(T_{vi}=175^{\circ}C)$ 



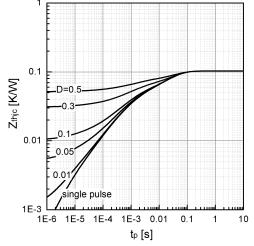
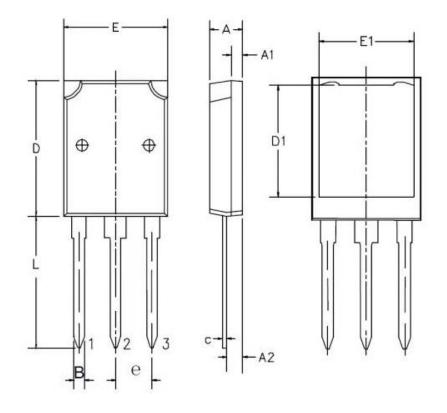


Fig 19. Transient thermal impedance of IGBT



# Package dimension

#### TO-247PLUS



Ref.	Min.(mm)	Typ.(mm)	Max.(mm)
А	4.92	5.00	5.08
A1	2.27	2.35	2.43
A2	1.92	2.00	2.08
В	1.16	1.20	1.24
С	0.58	0.60	0.62
D	20.80	20.90	21.00
Е	15.80	15.90	16.00
E1	13.94	14.02	14.10
e	5.34	5.44	5.54
L	19.80	20.00	20.20

### **Revision history**

Date	Revision	Changes
2024-05-30	Rev. 1.0	Release of the datasheet.
2024-09-25	Rev. 1.1	Update
2025-01-26	Rev. 1.2	Add SOA and Rth graph

### Disclaimer

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